

# Deep Learning Based Defect Detection System in Steel Sheet Surfaces

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**Abstract**—Steel is one of the most important building materials of modern times and the production process of flat sheet steel is complicated. Before shipping or delivering steel, sheets need to undergo a careful inspection procedure to avoid defects and thus localizing and classifying surface defects on a steel sheet is crucial. In this study, we advance the steel defect inspection methods by designing machine learning models that aim to detect multi-level defects from sample steel sheet images and classify them according to their corresponding classes. We explore two (2) deep learning methods including U-NET and Deep Residual U-NET to solve the steel defect detection problem with a Dice coefficient accuracy of 0.543 and .731 correspondingly.

**Keywords**—Deep Learning, U-NET, Deep Residual U-NET, Defect Detection, Steel Surface Images.

## I. INTRODUCTION

The defect detection system in steel sheet surfaces is playing a critical role in the steel sheets industry by detecting, localizing, recognizing and subsequently correcting causative factors. It is also quite necessary for controlling production quality and generating real-time analysis reports. Detecting process involves determining the existence of the steel surface defects from images taken from the industrial cameras. Localization locates all known content in the scene including the defect regions. Recognition takes the defect regions infers the defect category according to the defect appearance. Defect detection system in steel sheet surfaces is thus a combined process of detection, localization, and classification. Typically, in steel mills, human inspectors manually perform the defect detection process on steel sheet. However, this procedure is very time consuming, costly but lower efficient and does not meet up the requirement of real-time online defect detection. Many recent researches are conducted on a combined approach of computer vision with machine learning methods to solve the requirements for real-time online defect detection on steel sheet. However, they apply some morphological operations on high-frequency images generated by low cost industrial cameras and simple classifiers to solve the classification problem. Thus, these approaches lower accuracy and unable to handle complex problems including

multi-level classifications or localize the defected area within a single image.

In this study, we advance the steel defect inspection methods by applying modern segmentation approach to partition the image into various regions and designing a new machine learning model to feed the region pixels to detect the defect region from a single sample image of steel sheet and classify them according to their corresponding multi-level classes. We investigate among modern machine learning models including different deep neural network architectures and apply U-NET and Residual U-NET to solve the given problem. Dice coefficient method is used to trace the accuracy of the selected machine learning models.

The rest of the paper is organized as follows. Section 2 reviews the recent studies on different machine learning models and their contributions on defect detection on steel sheet surfaces problem solving. Section 3 explains the datasets and feature of data sets. Section 4 proposed the architectures of U-NET and Residual U-NET and the methodology of the propose model. Section 5 discusses the experiment results and their analyses. Concluding remarks are described in Sect. 6.

## II. RELATED WORK

Many researchers introduced computer vision steel surface inspection systems. Caleb and Steuer in [1] used artificial neural networks (ANN) to detect defects in hot rolled steel strip. Pakkanen et al in [2] applied edge histogram, color structure, and homogeneous texture as features extractor, and K-Nearest Neighbor as a classifier on hot-rolled steel strip surface to detect the defected images. Hongbin and Keesug et al in [3] applied Support Vector Machine (SVM) as a classifier of the inspection system, SVM gives better performance than ANN for their samples on hot rolling steel. Smriti and Bhandari in [4] considered edge detection with modified scheme based on heuristics used by human inspectors for identifying surface imperfections to compute the features then applied SVM as classifier for classifying surface images into two(2) classes defective and defect-free; the system was applied on surface texture database.

Sharifzadeh et al in [5] used image processing algorithms for detecting four popular classes of steel defects. Liu et al in [6] used a relevance vector machine as a classifier to detect four kinds of defects on the steel surface. Luiz et al in [7] adopted Principal Component Analysis as features extractor, and Self-Organizing Maps as a classifier to classify six classes of the hot-rolled steel surface defects. Song and Yan in [8] proposed a new method Adjacent Evaluation Completed Local Binary Patterns as feature extractor and employed SVM as classifier on Northeastern University (NEU) hot-rolled steel strip surface defect database. Song et al in [9] adopted a scattering convolution network as a feature extractor and employed SVM as a classifier on the NEU database. Wang et al [10] proposed fault diagnosis based on a continuous sparse auto-encoder and illustrated the effectiveness of the presented approach by IEC TC 10 dataset of transformers faults. Mao et al in [11] proposed an intelligent fault-diagnosis by the auto-encoder algorithm the effectiveness of the presented approach is verified by rolling element bearings data set. Lu et al in [12] used stacked de-noising auto-encoder as fault diagnosis method and rotating machinery datasets were employed to demonstrate the effectiveness of the proposed method.

With due respect to all related works referred above, this paper considers the performance of the algorithms Decision Tree, K-Neighbors, and Support Vector Machine (SVM), Principal component analysis (PCA), Self- Organizing Maps (SOM), Gabor filtering, Convolution neural network (CNN), and Bayesian network classifiers. However, the models were used as a classifier to recognize defect classes. Their analyses miss the detection of defective area or pixel locations. CNN is largely used when the whole image is needed to be classified as a class label. But many tasks require classifying each pixel of the image. This is solved by the U-NET and Res-Net. We also want to approach a combined model for defect classification and defect localization using segmentation and modern fully CNNs. To complete the above goal, we aim to explore image segmentation using U-NET and Residual U-NET. They both are efficient to solve multi-label defects on a single image and localize the defect on images.

### III. DATASET AND FEATURE

Our dataset [13] consist of steel sheet images, corresponding defects classes, and defect regions. Steel sheet images are categories into two parts including training and testing. There are 12568 training images and 1801 testing images of  $1600 \times 256 \times 1$  size each. Out of all the training images, 5902 images are with defects and 6666 images are without defects (fig.1). There are four labels of defects 1, 2, 3, and 4. A defected image may have multiple labels of defects from 1 to 4 in any combination. The distribution of all training images according to the four (4) defects is presented in fig.2. Sample image and defects are presented in fig.3.

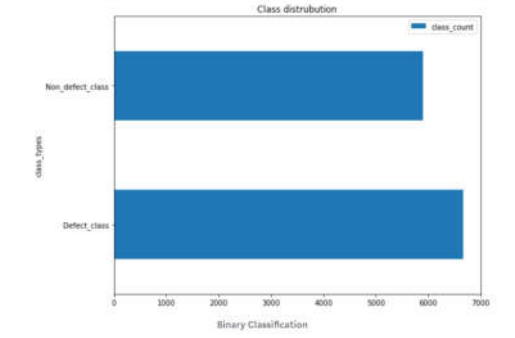


Figure 1: Defect and Non Defect Image Counts

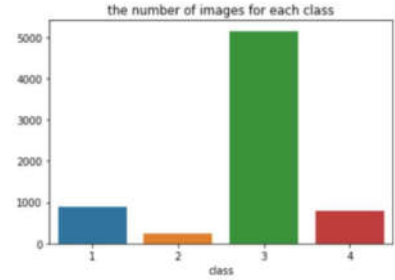


Figure 2: Sample image with defects

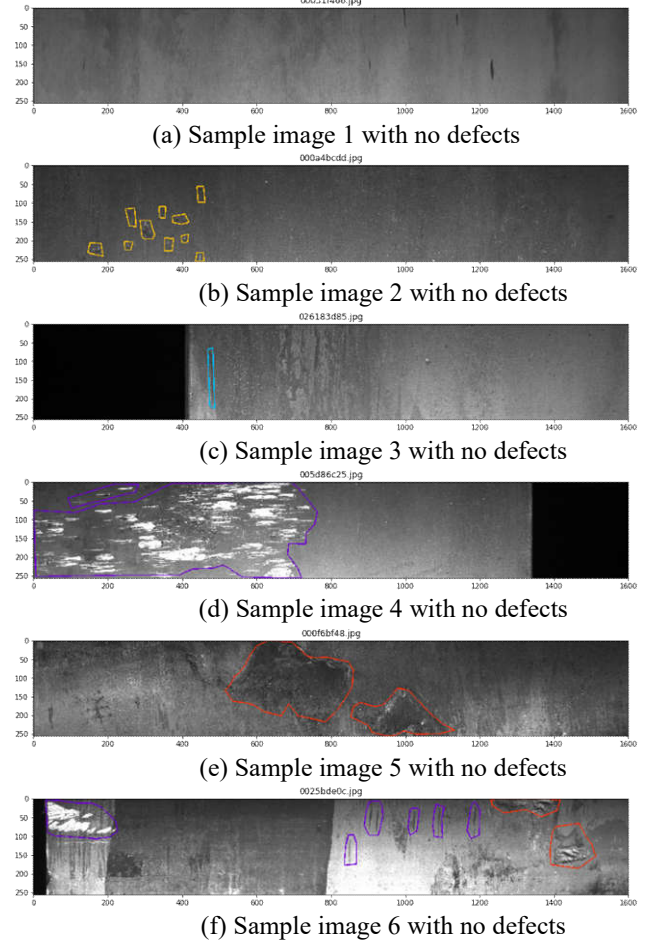


Figure 3: Sample image with instance-level defects

## IV. METHODOLOGY

### A. Residual Networks (Res-Net)

Given enough capacity or given enough neurons, a single layer feedforward NN is sufficient to represent any function. However, the layer may be massive and the network may have overfitting problem. Thus, a common solution on the above problem in NN research to go deeper. Thus, CNN architecture is going deeper. However, increasing network dept creates vanishing gradient problem and makes learning harder. The core idea of ResNet is to introduce by using the identity matrix. When the back-propagation is done through identity function, the gradient will be multiplied only by 1. This preserves the input and avoids any loss in the information. Thus Res-Net is a CNN with a heuristic implementation of the identity shortcut connection. Fig.4 presents the architecture of CNN with Res-Net Blocks.

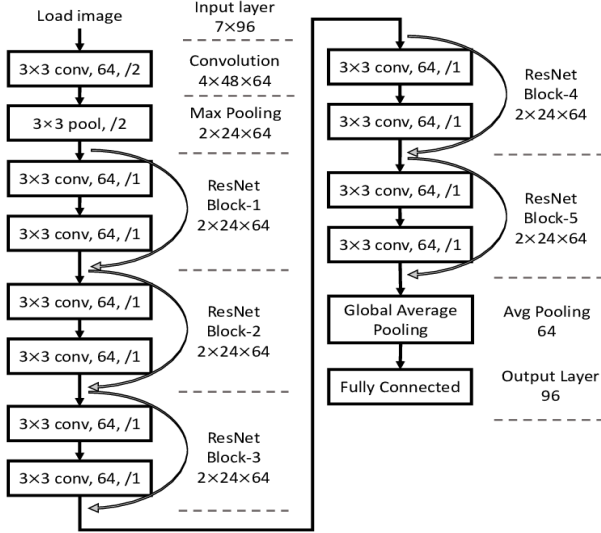


Figure 4: Architecture of Res-Net.

### B. U-NET

U-NET [14] architecture is presented in fig.5. It consists of a contracting path (the left side) and an expanding path (the right side). There are 4 down-sampling layers in the contracting path. Each down-sampling layer contains two 3x3 convolutional units, each followed by batch normalization and ReLU, and then a 2x2 max pooling. The contextual information from the contracting path is then transferred to the expanding path by skip connection. There are four (4) up-sampling layers in the expanding path. Each up-sampling layer contains a 2x2 transposed convolution, a concatenation with the corresponding feature maps from the encoding path, and two(2) 3x3 convolutional units, each followed by batch normalization and ReLU. Finally, there is a 1x1 convolutional layer and a SoftMax layer to map the feature vector at each pixel into five (5) different classes (0 for no defect, 1-4 for defects of different classes).

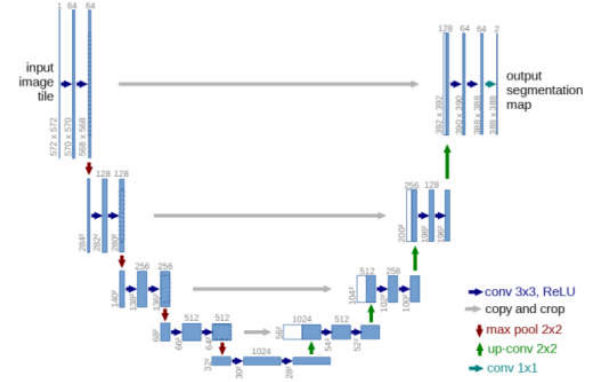


Figure 5: Architecture of the U-NET

### C. Deep Residual U-NET

Deep Residual U-NET [15] is presented in fig. 6. It is a semantic segmentation NN which combines strengths of both U-NET and Res-Net networks. This combination bring us two benefits: 1) the residual unit makes ease training of the network; 2) skip connections within a residual unit and between low levels and high levels of the network will facilitate information propagation without degradation, making it possible to design a neural network with much fewer parameters however could achieve comparable ever better performance on semantic segmentation. In our proposed work we utilize a 7-level deep architecture and comprises of three parts: encoding, bridge and decoding. The first part encodes the input image into compact representations. The last part recovers the representations to a pixel-wise categorization, i.e. semantic segmentation. The middle part serves like a bridge connecting the encoding and decoding paths. All of the three parts are built with residual units which consist of two  $3 \times 3$  convolution blocks and an identity mapping. Each convolution block includes a BN layer, a ReLU activation layer and a convolutional layer. The identity mapping connects input and output of the unit. Encoding path has three (3) residual units. In each unit, instead of using pooling operation to down sample, the feature map size, a stride of 2 is applied to the first convolution block to reduce the feature map by half. Correspondingly, decoding path composes of three residual units. Before each unit, there is an up-sampling of feature maps from lower level and a concatenation with the feature maps from the corresponding encoding path. After the last level of decoding path, a  $1 \times 1$  convolution and a sigmoid activation layer are used to project the multi-channel feature maps into the desired segmentation. In total we have 15 convolutional layers comparing with 23 layers of U-NET. It is worth noting that the indispensable cropping in U-NET is unnecessary in our network. The parameters and output size of each step are presented in Table-I.

TABLE I: THE NETWORK STRUCTURE OF RESUNET

	Unit level	Conv layer	Filter	Stride	Output size
Input					$224 \times 224 \times 3$
Encoding	Level 1	Conv 1	$3 \times 3/64$	1	$224 \times 224 \times 64$
		Conv 2	$3 \times 3/64$	1	$224 \times 224 \times 64$
	Level 2	Conv 3	$3 \times 3/128$	2	$112 \times 112 \times 128$
		Conv 4	$3 \times 3/128$	1	$112 \times 112 \times 128$
Bridge	Level 3	Conv 5	$3 \times 3/256$	2	$56 \times 56 \times 256$
		Conv 6	$3 \times 3/256$	1	$56 \times 56 \times 256$
	Level 4	Conv 7	$3 \times 3/512$	2	$28 \times 28 \times 512$
		Conv 8	$3 \times 3/512$	1	$28 \times 28 \times 512$
Decoding	Level 5	Conv 9	$3 \times 3/256$	1	$56 \times 56 \times 256$
		Conv 10	$3 \times 3/256$	1	$56 \times 56 \times 256$
	Level 6	Conv 11	$3 \times 3/128$	1	$112 \times 112 \times 128$
		Conv 12	$3 \times 3/128$	1	$112 \times 112 \times 128$
Output	Level 7	Conv 13	$3 \times 3/64$	1	$224 \times 224 \times 64$
		Conv 14	$3 \times 3/64$	1	$224 \times 224 \times 64$
		Conv 15	$1 \times 1$	1	$224 \times 224 \times 1$

## V. RESULT AND ANALYSIS

## A. Evaluation Metrics

Performance metrics including accuracy, precision, recall, F1 score are used to measure the performance of CNN and Res-Net networks in image to defect class classification. The Dice coefficient is used to compare the pixel-wise agreement between a predicted segmentation and its corresponding ground truth. The formula is given by:

$$\text{Dice}(X, Y) = \frac{2 \times |X \cap Y|}{|X| + |Y|} \quad \dots(1)$$

Where  $X$  is the predicted set of pixels and  $Y$  is the ground truth. The Dice coefficient is defined to be 1 when both  $X$  and  $Y$  are empty. We used Dice loss function during training, which is defined as

$$L_{\text{dice}} = 1 - \frac{1}{B} \sum_{i=1}^B \frac{2 \sum_{j=1}^n y_j^{(i)} \hat{y}_j^{(i)}}{\sum_{j=1}^n y_j^{(i)} + \sum_{j=1}^n \hat{y}_j^{(i)}} \quad \dots(2)$$

Where  $B$  is the batch size,  $n = 4 \times 256 \times 1600$  is the total number of pixels of the 4 defect classes,  $y_{j(i)}$  is the true label of each pixel (1 for defect and 0 for normal), and  $\hat{y}_{j(i)}$  is the predicted probability.

## B. Image-Class (Single Label) Classification

At first the multiple labels complex images are transformed to simple single defect class label image. The defect image class is the maximum defects class of the images. U-NET is much more suitable for segmentation based classification than pure Res-Net. Thus, we compare the classification performance between Res-Net and CNN.

TABLE II: PERFORMANCE OF CNN WITH RES-NET

	Accuracy	Recall	Precision	F1 Score
CNN	0.64	1.11	0.9806	1.0410
Res-Net	0.74	1.29	1.13	1.20

## C. Image Segmentation and Multi Labels Classification

We apply segmentation-based instance segmentation method which uses output of semantic segmentation as input and obtains instance-aware segmentation result.

U-NET is configured with batch size of 4 due to the limitation of GPU memory. Adam is used as the optimizer and Dice loss function during training. The loss values and the positive Dice score during training are shown in Fig. 7a and 7b, respectively. After 20 epochs, Dice scores results 0.543. The U-NET model presents good performance for predicting defects of class 3 (Fig. 7c). However, it fails to predict many defects of class 1, 2 and 4 (Fig. 7d).

Deep Residual U-NET is configured with batch size of 4 due to the limitation of GPU memory. We also use Adam as optimizer. We use Dice loss function during training. The loss values and the positive Dice score during training are shown in Fig. 8a and 8b, respectively. After 20 epochs, Dice scores are 0.731. The deep residual U-NET model shows good performance for predicting defects of all classes (Fig. 8c).

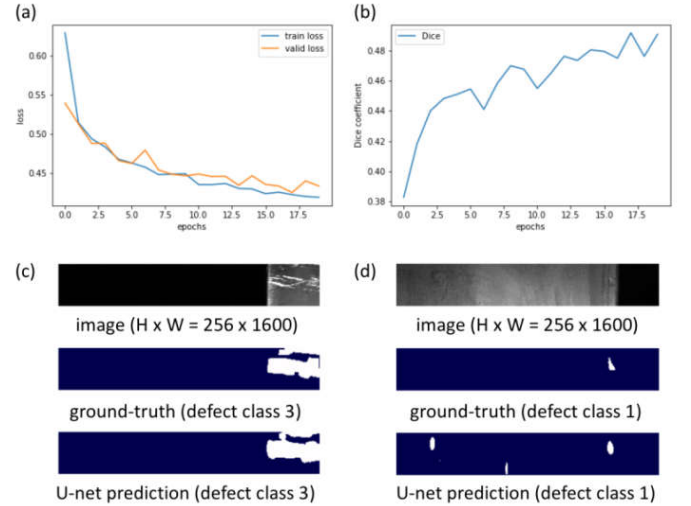
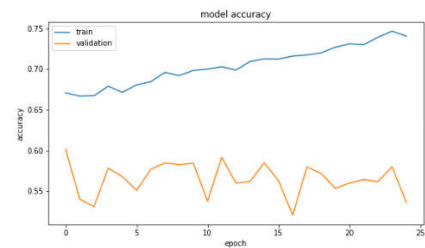


Figure 7: Results of the U-NET. (a) Loss of the training and the validation sets. (b) Average positive Dice score of the validation set during training. (c) A sample image containing defect of class 3. (d) A sample image containing defect of class 1.

a)



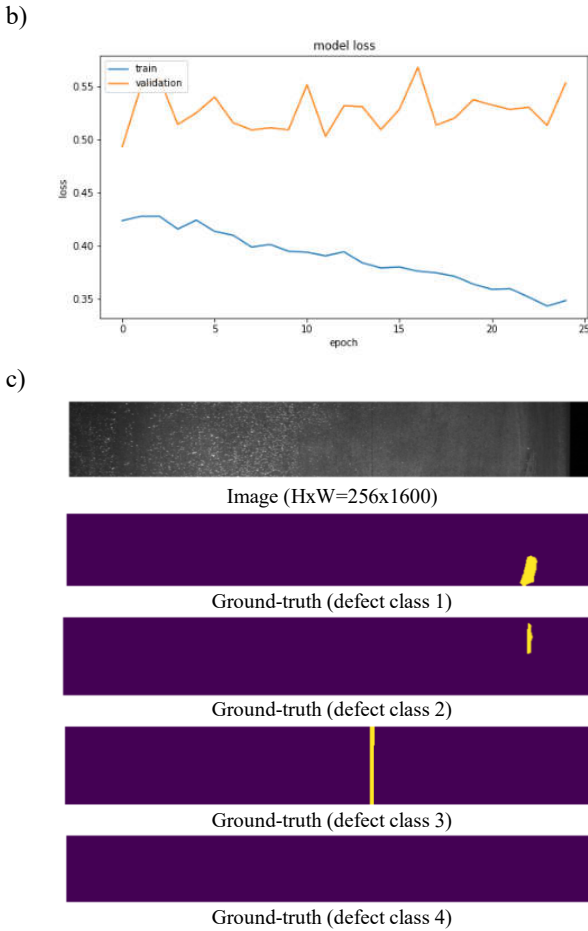


Figure 8: Results of the deep residual U-NET. (a) Accuracy of the training and the validation sets. (b) Accuracy of the training and the validation sets. (c) A sample image containing multiple defects.

## VI. CONCLUSION

The proposed work anchors the segmentation-based instance segmentation computer vision techniques and modern deep NNs including U-NET and Res-Net to solve the steel defect detection problem. The classification models (CNN and Res-Net) are applied on single image to single defect class and the accuracy is 10% better than CNN. Thus, it has been concluded that Res-Net or similar type of deep NN models can perform better in segmented images. Thus, we choose fully CNs (usually better perform in segmented image classification) to classify and localize the single image multiple labels defect classes. Res-Net uses identity matrix and able to bypass few Residual blocks. Thus, a new Deep Residual U-NET- a combined model of U-NET and Res-Net and apply them on image segmentation and region based multiple labels classification. Among U-NET and Residual U-

NET, Residual U-NET performs better with Dice Coefficient score of 0.731.

In near future, we will explore more deep NNs on this problem, analyze their performance and improve classification accuracy.

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